

## molex<sup>®</sup>

### PRODUCT SPECIFICATION

#### RIGHT ANGLE HIGH SPEED CAT 5E MODULAR JACK

#### 1.0 SCOPE

This specification covers the performance requirements of the Molex High Speed Cat 5e Right Angle Low Profile Modular Telephone Jacks. Where applicable, tests are in accordance with IEC 60603-7-2.

#### 2.0 PRODUCT DESCRIPTION

#### 2.1 PRODUCT NAME.

85503-\*\*\* High Speed Modular Jack Right Angle Low Profile.

### 2.2 DIMENSIONS, MATERIALS, PLATINGS AND MARKINGS

**CONTACT FINISH: GOLD** 

Post Plate 0.00127mm-0.00152mm Gold in contact area.

0.00190mm Min pure Tin in Tail area, both over 0.00127mm Min Nickel overall.

OR,

### PALLADIUM NICKEL WITH GOLD FLASH:

Post plate 0.00005mm Min Gold Flash over 0.00060mm Min Palladium Nickel in contact area, 0.00190mm Min pure Tin in tail area, both over 0.00127mm Min Nickel overall.

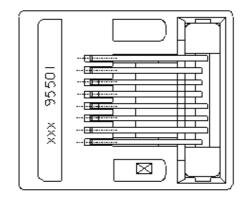
#### 3.0 APPLICABLE DOCUMENTS AND SPECIFICATIONS

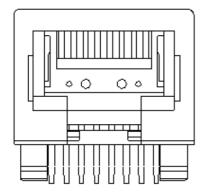
See the appropriate Sales Drawings and the other sections of this Specification for the necessary referenced Documents and Specifications.

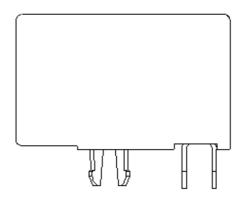
IEC 60603-7-2 TIA-1096-A

D REVISION:	ECR/ECN INFORMATION: EC No: IPG2013-0856  DATE: 2012 / Feb / 21	LOW PRODU	1 of 12		
DOCUMENT NUMBER:		CREATED / REVISED BY:	CHECKED BY:	APPR	OVED BY:
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### PRODUCT SPECIFICATION







### 4.0 RATINGS

## **4.1 VOLTAGE** 125 Volts d.c.

### 4.2 CURRENT

1.5 Amps max

### **4.3 TEMPERATURE**

Operating: -40° C to +85° C Non operating: -40° C to +85° C

REVISION:	ECR/ECN INFORMATION: EC No: IPG2013-0856  DATE: 2012 / Feb / 21	TITLE: RIGHT ANGLE HIGH SPEED CAT 5E LOW PROFILE MODULAR JACKS PRODUCT SPECIFICATION.			2 of 12
DOCUMENT NUMBER:		CREATED / REVISED BY:	CHECKED BY:	APPR	OVED BY:
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### PRODUCT SPECIFICATION

### **5.0 TEST SCHEDULES**

The following tests specify the characteristics to be checked and the requirements to be fulfilled.

For a complete test sequence, a minimum of 62 specimens are needed. This equals 6 groups of 10, and 1 group of 2. The group of 2 is for transmission testing, group EP.

All connectors in each group shall undergo the following tests as described in the sequence given, required alteration of the sequence of tests or adding of new tests to verify additional connector characteristics.

All the test group specimens shall be subjected to the preliminary group P tests in the following sequence.

### Test group P

TEST PHASE	TITLE	SEVERITY	REQUIREMENTS
P 1	GENERAL EXAMINATION	Visual examination	There shall be no defects that would
	PER IEC 60512-1-1, Test 1a		impair normal operation
P2		N/A	
Р3	CONTACT RESISTANCE	Mated connectors:	Initial 20 mΩ
	IEC 60512-2-1, Test 2a	(Measurement points per section 7.0)	maximum
P 4	INSULATION RESISTANCE IEC 60512-3-1, Test 3a, Method a.	Test voltage 100 Vd.c. Method A mated connectors	500 MΩ Minimum
P 5	VOLTAGE PROOF	Contact/contact Method A	1000 V d.c. or a.c.
. 0	IEC 60512-4-1, Test 4a, Method a.	Mated Connector	peak

<b>D</b>	EC No: IPG2013-0856  DATE: 2012 / Feb / 21	LOW PROFILE MODULAR JACKS PRODUCT SPECIFICATION.		3 of 12	
DOCUMENT NUMBER:		CREATED / REVISED BY:	CHECKED BY:	APPR	OVED BY:
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## PRODUCT SPECIFICATION

Test group AP

TEST PHASE	TITLE	SEVERITY	REQUIREMENTS
AP 1	INSERTION AND WITHDRAWAL FORCES PER IEC 60512-13-2, Test 13b	Connector locking device depressed.	Insertion force 20 N max, Withdrawal force 20 N max.
AP 2	EFFECTIVENESS OF CONNECTOR COUPLING DEVICE.	Rate of load application 44,5 N/S Max	50N for 60s ± 5s
AP 3	PER IEC 60512-15-6, Test 15f  RAPID CHANGE OF  TEMPERATURE  PER IEC 60512-11-4	-40°C to 70°C Mated connectors 25 cycles I = 30 min recovery time 2 h	
AP 4	INSULATION RESISTANCE IEC 60512-3-1, Test 3a, Method a.	Test voltage 100 v ±15 v d.c. method a mated connectors	PER P4
AP 5	CONTACT RESISTANCE  IEC 60512-2-1, Test 2a	PER P3	20 mΩ maximum change from initial
AP 6	VOLTAGE PROOF  IEC 60512-4-1, Test 4a,  Method a.	PER P5	PER P5
AP 7	VISUAL EXAMINATION	PER P1	PER P1
AP 8	CYCLIC DAMP HEAT PER IEC 60068-2-38	21 cycles low temperature 25°C high temperature 65°C cold subcycle –10°C humidity 93 % Half of the samples in mated state Half of the samples in unmated state	
AP 9	CONTACT RESISTANCE  IEC 60512-2-1, Test 2a	PER P3	20 mΩ maximum change from initial for signal contacts. Input to output resistance 100 mΩ max for screen.

REVISION:	ECR/ECN INFORMATION: EC No: IPG2013-0856	LOW PROFILE MODULAR JACKS			SHEET No.
D	DATE: 2012 / Feb / 21	PRODU	JCT SPECIFICATION	l.	<b>4</b> of <b>12</b>
DOCUMENT NUMBER:		CREATED / REVISED BY:	CHECKED BY:	APPR	OVED BY:
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## PRODUCT SPECIFICATION

Test group AP(continued).

TEST PHASE	TITLE	SEVERITY	REQUIREMENTS
AP 10	INSERTION AND WITHDRAWAL FORCES	PER AP1	PER AP1
	PER IEC 60512-13-2, Test 13b		
AP 11	EFFECTIVENESS OF CONNECTOR COUPLING PER IEC 60512-15-6, Test 15f	PER AP2	PER AP2
AP 12	VISUAL EXAMINATION	PER P1	PER P1
AP 13	SOLDERABILITY	Solder Bath 260+0/-5°C Immersion Time 2,0 +/- 0.5s	The Dipped surface shall be covered with a smooth and bright solder coating. Some imperfections are acceptable but NOT concentrated in the same area.
AP 14	RESISTANCE TO SOLDERING HEAT	For recommended Reflow Profile (See Section 6.0)	Appearance: No Damage.
AP 15	VOLTAGE PROOF  IEC 60512-4-1, Test 4a, Method a.	PER P5	PER P5

D REVISION:	EC No: IPG2013-0856  DATE: 2012 / Feb / 21	LOW PRODU	5 of 12		
DOCUMEN	IT NUMBER:	CREATED / REVISED BY:	CHECKED BY:	APPR	OVED BY:
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## PRODUCT SPECIFICATION

### Test group BP

TEST PHASE	TITLE	SEVERITY	REQUIREMENTS
BP 1		N/A	
BP 2	MECHANICAL OPERATIONS PER IEC 60512-9-1, Test 9a	Mate connectors 1,250 cycles, at a maximum rate of 10mm/s maximum. Rest 1s (when mated and when unmated) Locking device inoperative.	
BP 3	FLOWING MIXED GAS CORROSION PER IEC 60512-11-7, Test 11g	Method 1, 4 days Half of the samples in mated state Half of the samples in unmated state	
BP 4	CONTACT RESISTANCE  IEC 60512-2-1, Test 2a	PER P3	20 mΩ maximum change from initial
BP 5	MECHANICAL OPERATIONS PER IEC 60512-9-1, Test 9a	Mate connectors 1,250 cycles, at a maximum rate of 10mm/s maximum. Rest 5s (when unmated) locking device inoperative.	
BP 6	CONTACT RESISTANCE  IEC 60512-2-1, Test 2a	PER P3	20 mΩ maximum change from initial.
BP 7	INSULATION RESISTANCE  IEC 60512-3-1, Test 3a,  Method a.	Test voltage 100 v ±15 v d.c. method a mated connectors	PER P4
BP 8	VOLTAGE PROOF IEC 60512-4-1, Test 4a, Method a.	PER P5	PER P5
BP 9	VISUAL EXAMINATION	PER P1	PER P1

D REVISION:	ECR/ECN INFORMATION: EC No: IPG2013-0856  DATE: 2012 / Feb / 21	RIGHT AND LOW PRODU	SHEET No.  6 of 12		
DOCUMENT NUMBER:		CREATED / REVISED BY:	CHECKED BY:	APPR(	OVED BY:
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## PRODUCT SPECIFICATION

### Test group CP

TEST PHASE	TITLE	SEVERITY	REQUIREMENTS
CP 1	VIBRATION	f = 10 Hz to 500 Hz, Amplitude: 0.35 mm Accel 50m/s² 10 sweeps / axis measurement points per section 7.0	Discontinuities 10µs maximum.
	PER IEC 60512-6-4, Test 6d (See Section 7.0)	(For arrangement,See IEC 60603-7, 7.3)	
CP 2	CONTACT RESISTANCE  No disturbance of the free connector to fixed connector electrical connections, between vibration test and contact resistance measurement  IEC 60512-2-1, Test 2a	PER P3	20 mΩ maximum change from initial.
CP 3	INSULATION RESISTANCE IEC 60512-3-1, Test 3a, Method a.	PER P4	PER P4
CP 4	VISUAL EXAMINATION	PER P1	PER P1

D REVISION:	ECR/ECN INFORMATION:  EC No: IPG2013-0856  DATE: 2012 / Feb / 21	LOW PRODU	7 of 12		
DOCUMENT NUMBER:		CREATED / REVISED BY:	CHECKED BY:	APPR	OVED BY:
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## PRODUCT SPECIFICATION

### Test group DP

TEST PHASE	TITLE	SEVERITY	REQUIREMENTS
DP 1	ELECTRICAL LOAD AND TEMPERATURE	500 h 70° C Recovery period 2 h	0.8A 5 connectors, no current 5 connectors
	PER IEC 60512-9-2, Test 9b		301111001010
	INSULATION RESISTANCE		
DP 2	IEC 60512-3-1, Test 3a, Method	PER P4	PER P4
	a. VOLTAGE PROOF		
DP 3	IEC 60512-4-1, Test 4a, Method	PER P5	PER P5
DP 4	VISUAL EXAMINATION	PER P1	PER P1
DP 5	CONTACT RESISTANCE  IEC 60512-2-1, Test 2a	PER P3	20 mΩ maximum change from initial.
DP 6	MECHANICAL GAUGING PER IEC 60603-7-3, Annex L	Both, free and fixed Connector	Passing go / no go test
DP 7	GAUGING CONTINUITY	All signal contacts and screen/specimens	10 μs maximum
	PER IEC 60603-7-3, Annex A		

REVISION:	ECR/ECN INFORMATION: EC No: IPG2013-0856  DATE: 2012 / Feb / 21	LOW PRO	SLE HIGH SPEED CA FILE MODULAR JAC JCT SPECIFICATION	CKS	8 of <b>12</b>
DOCUMENT NUMBER:		CREATED / REVISED BY:	CHECKED BY:	APPR	OVED BY:
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Test group EP

TEST PHASE	TITLE	SEVERITY	REQUIREMENTS
EP 1	INSERTION LOSS IEC 60512-27-1,Test a	All pairs, one direction.	≤0,04x √f dB from 1 MHz to 100MHz
EP 2	NEXT IEC 60512-27-3, Test c	All pairs, both directions, (pair to pair)	All Pairs: ≥ 83 – 20log(f) dB from 1 MHz to 100 MHz
EP 3	RETURN LOSS IEC 60512-27-2, Test b	All pairs, both directions	All Pairs: ≥ 60 – 20log(f) dB from 1 MHz to 100 MHz
EP 4	FEXT IEC 60512-27-4, Test d	All pairs, both directions, (pair to pair)	All Pairs: ≥ 75, 1 – 20log(f) dB from 1 MHz to 100 MHz
EP 5	TRANSVERSE CONVERSION LOSS IEC 60512-27-6, Test f		All Pairs: ≥ 68 – 20log(f) dB from 1 MHz to 100 MHz
EP 6	TRANSVERSE CONVERSION TRANSFER LOSS IEC 60512-27-7, Test g		All Pairs: ≥ 68 – 20log(f) dB from 1 MHz to 100 MHz
EP 7	INPUT TO OUTPUT RESISTANCE PER IEC 60512-2-1, Test 2a	Mate Connectors	Mated Connectors Cable termination to Cable Termination All types: 200 mΩ maximum.
EP 8	RESISTANCE UNBALANCE IEC 60512-2-1,Test 2a PER IEC 60603-7-3	Millivolt level method	Unbalance resistance = 50 mΩ maximum.

### Test group FP

TEST PHASE	TITLE	SEVERITY	REQUIREMENTS
FP 1	SURGE TEST PER IEC 60512, Test no. ITU_T K.20	Mated connectors, Table 2a /2b, Basic test level Tests 2.1.1a, 2.1.1b, 2.1.3, 2.2.1a and 2.3.1A	Test 2.1 & 2.2: Acceptance criteria A per ITU-T K.44, clause 9, Test 2.3: Acceptance criteria B PER ITU-T K.44, CLAUSE 9,
FP 2	INSULATION RESISTANCE IEC 60512-3-1, Test 3a, Method a.	Test voltage 100 v ±15 v d.c. method a	PER P4
FP 3	VISUAL EXAMINATION	mated connectors PER P1	PER P1

D REVISION:	EC No: IPG2013-0856  DATE: 2012 / Feb / 21	LOW PRODU	9 of 12	
DOCUMENT NUMBER:		CREATED / REVISED BY: CHECKED BY: APPROVED BY:		OVED BY:
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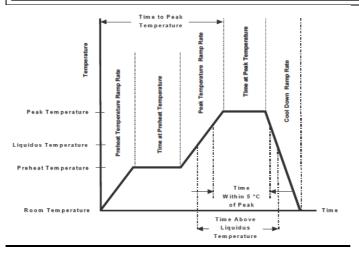
### PRODUCT SPECIFICATION

### Test group AZ

TEST PHASE	TITLE	SEVERITY	REQUIREMENTS
AZ1	HIGH TEMPERATURE (DRY HEAT) PER IEC 60068-2-2, Test 9b	Mate connectors; expose to: 96 hours at 85 ± 2°C	Use Molex plug 500602-0819
A7 2	CONTACT RESISTANCE	PER P3	20 mΩ maximum change from initial for signal contacts.
	IEC 60512-2-1, Test 2a		Input to output resistance 100 mΩ max for screen.

## 6.0 SOLDERING CONDITIONS. RECOMMENDED

#### REFLOW SOLDERING SIMULATION PEAK PROFILE REFLOW AT 260 °C **DESCRIPTION** REQUIREMENT Solder Type None Solder Flux Type None Paste Flux Type None Average Ramp Rate 3 °C/second maximum Preheat Temperature 150 °C minimum; 200 °C maximum 60 to 180 seconds Preheat Time Ramp to Peak 3 °C/second maximum Time over Liquidus (217 °C) 60 to 150 seconds 260 °C +0/-5 °C Peak Temperature Time within 5 °C of peak 20 to 40 seconds Ramp - Cool Down 6 °C/second maximum Time 25 °C to Peak 8 minutes maximum



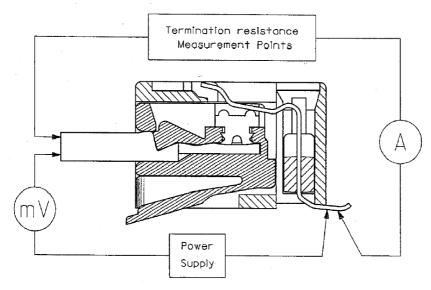
REVISION:	ECR/ECN INFORMATION:	TITLE: RIGHT AND	GLE HIGH SPEED CA	AT 5E	SHEET No.
р	EC No: <b>IPG2013-0856</b>	LOW PROFILE MODULAR JACKS		<b>10</b> of <b>12</b>	
0	DATE: 2012 / Feb / 21	PRODU	PRODUCT SPECIFICATION.		
DOCUMEN	T NUMBER:	CREATED / REVISED BY:	CHECKED BY:	APPRO	OVED BY:
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### 7.0 GAUGES AND FIXTURES

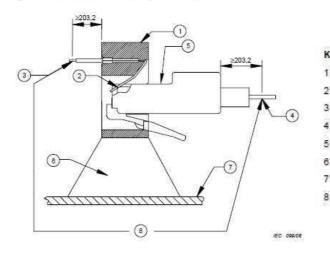
Termination Resistance Measurement Points



System resistance equals millivolt drop (mV) divided by test current (A) ( Conductor resistance will be deducted from measurement,)

### **VIBRATION**

Arrangement for vibration test (test phase CP1)



Fixed connector vibration feature.

Contact point.

Point A: secure to the non-vibrating member.

Point C: secure to the non-vibrating member.

Free connector.

Fixed connector rigidly fixed to the mounting plate.

TEMPLATE FILENAME: PRODUCT\_SPEC[SIZE\_A4](V.1).DOC

Mounting plate.

Contact resistance measurement point.

Arrangement for vibration test FROM IEC-60603-7

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D	EC No: IPG2013-0856  DATE: 2012 / Feb / 21	PRODUCT SPECIFICATION. 11 of 12		<b>11</b> of <b>12</b>	
DOCUMENT NUMBER:		CREATED / REVISED BY: CHECKED BY: APPROVED BY		OVED BY:	
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### 8.0 PACKAGING

Parts shall be packaged to protect against damage during handling, transit and storage.

### 9.0 QUALITY ASSURANCE PROVISIONS

The applicable Molex inspection plan specifies the sampling acceptable quality level to be used. Dimensional and functional requirements shall be in accordance with applicable product drawings and this specification.

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REVISION:	ECR/ECN INFORMATION: EC No: IPG2013-0856  DATE: 2012 / Feb / 21	LOW PRO	SLE HIGH SPEED CA FILE MODULAR JAC JCT SPECIFICATION	CKS	12 of 12
DOCUMENT NUMBER:		CREATED / REVISED BY:	CHECKED BY:	APPR	OVED BY:
PS-85503-001		D.Byrnes	A.Higgins	S.C	Griffin
	TEMPLATE FILENAME: PRODUCT, SPECISIZE, A41(V, 1) DOC				